

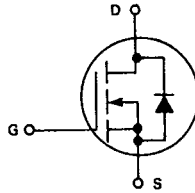
T-39-11

MOTOROLA
SEMICONDUCTOR
TECHNICAL DATA

Power Field Effect Transistor
N-Channel Enhancement-Mode
Silicon Gate TMOS

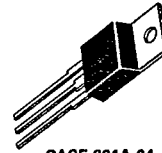
These TMOS Power FETs are designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds
- Low $r_{DS(on)}$ to Minimize On-Losses. Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads



IRF820
IRF821
IRF823

TMOS POWER FETs
2 and 2.5 AMPERES
 $r_{DS(on)} = 3 \text{ OHM}$
450 and 500 VOLTS
 $r_{DS(on)} = 4 \text{ OHM}$
450 VOLTS



CASE 221A-04
TO-220AB

MAXIMUM RATINGS

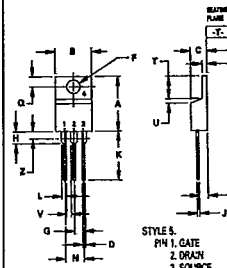
| Rating | Symbol | IRF | | | Unit |
|---|----------------|------------|-----|-----|------------------|
| | | 820 | 821 | 823 | |
| Drain-Source Voltage | V_{DSS} | 500 | 450 | 450 | Vdc |
| Drain-Gate Voltage ($R_{GS} = 1 \text{ M}\Omega$) | V_{DGR} | 500 | 450 | 450 | Vdc |
| Gate-Source Voltage | V_{GS} | ± 20 | | | Vdc |
| Drain Current | I_D | 2.5 | 2 | 8 | Adc |
| | I_{DM} | | | | |
| Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C | P_D | 40 | | | Adc |
| | | 0.32 | | | |
| Operating and Storage Temperature Range | T_J, T_{stg} | -55 to 150 | | | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| | | | |
|--|-----------------|------|--------------------|
| Thermal Resistance Junction to Case | $R_{\theta JC}$ | 3.12 | $^\circ\text{C/W}$ |
| Junction to Ambient | $R_{\theta JA}$ | 62.5 | |
| Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds | T_L | 300 | $^\circ\text{C}$ |

See the MTP3N45 Designer's Data Sheet for a complete set of design curves for the product on this data sheet.

OUTLINE DIMENSIONS



- NOTES:
1. DIMENSIONS AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIM Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|-------|--------|-------|
| | MIN | MAX | MIN | MAX |
| A | 14.48 | 15.75 | 0.570 | 0.620 |
| B | 8.68 | 10.20 | 0.340 | 0.405 |
| C | 4.07 | 4.83 | 0.160 | 0.190 |
| D | 0.64 | 0.98 | 0.025 | 0.039 |
| F | 3.61 | 3.73 | 0.142 | 0.147 |
| G | 2.47 | 2.66 | 0.095 | 0.126 |
| H | 2.80 | 2.93 | 0.110 | 0.116 |
| J | 0.36 | 0.55 | 0.014 | 0.022 |
| K | 12.20 | 14.27 | 0.500 | 0.562 |
| L | 1.15 | 1.38 | 0.045 | 0.055 |
| M | 4.83 | 5.30 | 0.190 | 0.210 |
| Q | 2.54 | 3.04 | 0.100 | 0.120 |
| R | 2.04 | 2.78 | 0.080 | 0.110 |
| S | 1.15 | 1.38 | 0.045 | 0.055 |
| T | 5.97 | 6.47 | 0.235 | 0.255 |
| U | 0.50 | 1.27 | 0.020 | 0.050 |
| V | 1.15 | — | 0.045 | — |
| Z | — | 2.04 | — | 0.080 |

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

| Characteristic | Symbol | Min | Max | Unit | |
|---|--------------------------|-------------------|------------|-----------|------|
| OFF CHARACTERISTICS | | | | | |
| Drain-Source Breakdown Voltage (V _{GS} = 0, I _D = 0.25 mA) | IRF821, IRF823 IRF820 | V(BR)DSS | 450 500 | — — | Vdc |
| Zero Gate Voltage Drain Current (V _{DS} = Rated V _{DSS} , V _{GS} = 0) (V _{DS} = 0.8 Rated V _{DSS} , V _{GS} = 0, T _J = 125°C) | | I _{DSS} | — — | 0.25 1 | mAdc |
| Gate-Body Leakage Current, Forward (V _{GSF} = 20 Vdc, V _{DS} = 0) | | I _{GSSF} | — | 500 | nAdc |
| Gate-Body Leakage Current, Reverse (V _{GSR} = 20 Vdc, V _{DS} = 0) | | I _{GSSR} | — | 500 | nAdc |

ON CHARACTERISTICS*

| | | | | | |
|--|--------------------------|---------------------|----------|--------|------|
| Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 0.25 mA) | | V _{GS(th)} | 2 | 4 | Vdc |
| Static Drain-Source On-Resistance (V _{GS} = 10 Vdc, I _D = 1 Adc) | IRF820, IRF821 IRF823 | r _{DS(on)} | — — | 3 4 | Ohm |
| On-State Drain Current (V _{GS} = 10 V) (V _{DS} ≥ 7.5 Vdc) (V _{DS} ≥ 8 Vdc) | IRF820, IRF821 IRF823 | I _{D(on)} | 2.5 2 | — — | Adc |
| Forward Transconductance (V _{DS} ≥ 7.5 V, I _D = 1 A) (V _{DS} ≥ 8 V, I _D = 1 A) | IRF820, IRF821 IRF823 | g _{FS} | 1 1 | — — | mhos |

DYNAMIC CHARACTERISTICS

| | | | | | |
|------------------------------|---|------------------|---|-----|----|
| Input Capacitance | (V _{DS} = 25 V, V _{GS} = 0, f = 1 MHz) | C _{iss} | — | 400 | pF |
| Output Capacitance | | C _{oss} | — | 150 | |
| Reverse Transfer Capacitance | | C _{rss} | — | 40 | |

SWITCHING CHARACTERISTICS*

| | | | | | |
|---------------------|--|---------------------|----------|----|----|
| Turn-On Delay Time | V _{DD} ≈ 200 V, I _D = 1 Apk, R _{gen} = 50 Ohms) | t _{d(on)} | — | 60 | ns |
| Rise Time | | t _r | — | 50 | |
| Turn-Off Delay Time | | t _{d(off)} | — | 60 | |
| Fall Time | | t _f | — | 30 | |
| Total Gate Charge | (V _{GS} = 10 V, V _{DS} = 0.8 x Rated V _{DSS} , I _D = Rated I _D) | Q _g | 12 (Typ) | 15 | nC |
| Gate-Source Charge | | Q _{gs} | 6 (Typ) | — | |
| Gate-Drain Charge | | Q _{gd} | 6 (Typ) | — | |

SOURCE-DRAIN DIODE CHARACTERISTICS*

| | | | | | |
|-----------------------|---|-----------------|-----------------------------|--------|-----|
| Forward On-Voltage | I _S = Rated I _D , V _{GS} = 0) | V _{SD} | — | 1.5(1) | Vdc |
| Forward Turn-On Time | | t _{on} | Limited by stray inductance | | |
| Reverse Recovery Time | | t _{rr} | 500 (Typ) | — | ns |

INTERNAL PACKAGE INDUCTANCE

| | | | | |
|--|----------------|------------------------|---|----|
| Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die) | L _d | 3.5 (Typ) 4.5 (Typ) | — | nH |
| Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad) | L _s | 7.5 (Typ) | — | |

*Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 (1) Add 0.1 V for IRF820 and IRF821.